# Three Level NPC Q2Pack Module

# NXH350N100H4Q2F2P1G, NXH350N100H4Q2F2S1G, NXH350N100H4Q2F2S1G-R, NXH350N100H4Q2F2P1G-R

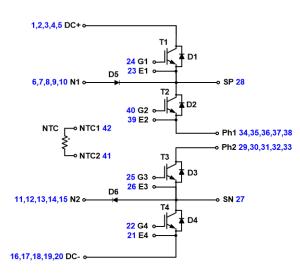
This high-density, integrated power module combines high-performance IGBTs with rugged anti-parallel diodes.

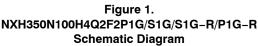
#### Features

- Extremely Efficient Trench with Field Stop Technology
- Low Switching Loss Reduces System Power Dissipation
- Module Design Offers High Power Density
- Low Inductive Layout
- Low Package Height
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

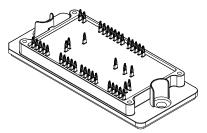
#### **Typical Applications**

- Solar Inverters
- Uninterruptable Power Supplies Systems

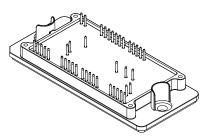


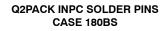


#### PACKAGE PICTURE



Q2PACK INPC PRESS FIT PINS CASE 180BH





#### MARKING DIAGRAM



G = Pb-Free Package AT = Assembly & Test Site Code

YYWW = Year and Work Week Code

#### **PIN CONNECTIONS**

See details pin connections on page 2 of this data sheet.

#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 5 of this data sheet.

### NXH350N100H4Q2F2P1G, NXH350N100H4Q2F2S1G, NXH350N100H4Q2F2S1G-R, NXH350N100H4Q2F2P1G-R PIN CONNECTIONS

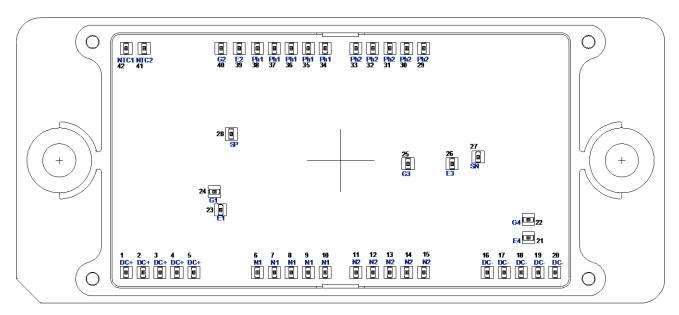


Figure 2. Pin Connections

#### **ABSOLUTE MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
OUTER IGBT (T1, T4)			
Collector-Emitter Voltage	V <sub>CES</sub>	1000	V
Gate-Emitter Voltage Positive Transient Gate-Emitter Voltage (T <sub>pulse</sub> = 5 μs, D < 0.10)	V <sub>GE</sub>	±20 30	V
Continuous Collector Current @ $T_C = 80^{\circ}C$	۱ <sub>C</sub>	303	А
Pulsed Peak Collector Current @ $T_C = 80^{\circ}C (T_J = 150^{\circ}C)$	I <sub>C(Pulse)</sub>	909	А
Maximum Power Dissipation ( $T_J = 150^{\circ}C$ )	P <sub>tot</sub>	592	W
Minimum Operating Junction Temperature	T <sub>JMIN</sub>	-40	°C
Maximum Operating Junction Temperature	T <sub>JMAX</sub>	175	°C
INNER IGBT (T2, T3)			
Collector-Emitter Voltage	V <sub>CES</sub>	1000	V
Gate-Emitter Voltage Positive Transient Gate-Emitter Voltage (T <sub>pulse</sub> = 5 μs, D < 0.10)	V <sub>GE</sub>	±20 30	V
Continuous Collector Current @ $T_C = 80^{\circ}C$	۱ <sub>C</sub>	298	А
Pulsed Peak Collector Current @ $T_C = 80^{\circ}C (T_J = 150^{\circ}C)$	I <sub>C(Pulse)</sub>	894	А
Maximum Power Dissipation ( $T_J = 175^{\circ}C$ )	P <sub>tot</sub>	731	W
Minimum Operating Junction Temperature	T <sub>JMIN</sub>	-40	°C
Maximum Operating Junction Temperature	T <sub>JMAX</sub>	175	°C
IGBT INVERSE DIODE (D1, D2, D3, D4)			
Peak Repetitive Reverse Voltage	V <sub>RRM</sub>	1000	V
Continuous Forward Current @ T <sub>C</sub> = 80°C	١ <sub>F</sub>	133	А
Repetitive Peak Forward Current ( $T_J = 175^{\circ}C$ )	I <sub>FRM</sub>	399	А
Maximum Power Dissipation ( $T_J = 175^{\circ}C$ )	P <sub>tot</sub>	276	W

Rating	Symbol	Value	Unit
IGBT INVERSE DIODE (D1, D2, D3, D4)			•
Minimum Operating Junction Temperature	T <sub>JMIN</sub>	-40	°C
Maximum Operating Junction Temperature	T <sub>JMAX</sub>	175	°C
NEUTRAL POINT DIODE (D5, D6)			
Peak Repetitive Reverse Voltage	V <sub>RRM</sub>	1200	V
Continuous Forward Current @ $T_C = 80^{\circ}C$	l <sub>F</sub>	98	А
Repetitive Peak Forward Current (T <sub>J</sub> = 175°C)	I <sub>FRM</sub>	294	А
Maximum Power Dissipation ( $T_J = 175^{\circ}C$ )	P <sub>tot</sub>	239	W
Minimum Operating Junction Temperature	T <sub>JMIN</sub>	-40	°C
Maximum Operating Junction Temperature	T <sub>JMAX</sub>	175	°C
THERMAL PROPERTIES			
Operating Temperature under Switching Condition	T <sub>VJOP</sub>	-40 to +150	°C
Storage Temperature Range	T <sub>stg</sub>	-40 to +125	°C
INSULATION PROPERTIES			
Isolation Test Voltage, t = 1 s, 50 Hz (Note 2)	V <sub>is</sub>	4000	V <sub>RMS</sub>
Creepage Distance		12.7	mm
Comparative Tracking Index	CTI	> 600	

Stresses exceeding those listed in the Maximum Hatings table may damage the device. If any of these limits are exceeded should not be assumed, damage may occur and reliability may be affected.
1. Refer to <u>ELECTRICAL CHARACTERISTICS</u> and/or APPLICATION INFORMATION for Safe Operating parameters.
2. 4000 VAC<sub>RMS</sub> for 1 second duration is equivalent to 3333 VAC<sub>RMS</sub> for 1 minute duration. ı,

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}C$ unless otherwise specified)

Characteristic	Test Conditions	Symbol	Min	Тур	Max	Unit
OUTER IGBT (T1, T4) CHARACTER	RISTICS		-			
Collector-Emitter Cutoff Current	$V_{GE} = 0 \text{ V}, \text{ V}_{CE} = 1000 \text{ V}$	I <sub>CES</sub>	-	-	1000	μA
Collector-Emitter Saturation Voltage	$V_{GE}$ = 15 V, I <sub>C</sub> = 375 A, T <sub>J</sub> = 25°C	V <sub>CE(sat)</sub>	—	1.63	2.3	V
	$V_{GE}$ = 15 V, I <sub>C</sub> = 375 A, T <sub>J</sub> = 150°C		—	1.92	-	
Gate-Emitter Threshold Voltage	$V_{GE} = V_{CE}, I_C = 375 \text{ mA}$	V <sub>GE(TH)</sub>	3.8	4.84	6.1	V
Gate Leakage Current	$V_{GE}$ = ±20 V, $V_{CE}$ = 0 V	I <sub>GES</sub>	_	-	±2000	nA
Turn-on Delay Time	$T_{\rm J} = 25^{\circ}{\rm C}$	t <sub>d(on)</sub>	_	85	-	ns
Rise Time	V <sub>CE</sub> = 600 V, I <sub>C</sub> = 150 A V <sub>GF</sub> = –9 V, 15 V, R <sub>G</sub> = 6 Ω	t <sub>r</sub>	_	27	-	
Turn-off Delay Time		t <sub>d(off)</sub>	—	319	-	
Fall Time		t <sub>f</sub>	_	52	-	
Turn-on Switching Loss per Pulse		E <sub>on</sub>	-	2.5	-	mJ
Turn-off Switching Loss per Pulse		E <sub>off</sub>	_	4.9	-	
Turn-on Delay Time	$T_{\rm J} = 125^{\circ}C$	t <sub>d(on)</sub>	_	80	-	ns
Rise Time	V <sub>CE</sub> = 600 V, I <sub>C</sub> = 150 A V <sub>GE</sub> = -9 V, 15 V, R <sub>G</sub> = 6 Ω	tr	—	31	-	
Turn-off Delay Time		t <sub>d(off)</sub>	_	355	-	
Fall Time		t <sub>f</sub>	-	70	-	
Turn-on Switching Loss per Pulse		Eon	_	3.1	_	mJ
Turn-off Switching Loss per Pulse	]	E <sub>off</sub>	_	7.3	-	

### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified) (continued)

Characteristic	Test Conditions	Symbol	Min	Тур	Max	Unit	
OUTER IGBT (T1, T4) CHARACTERISTICS							
Input Capacitance	$V_{CE}$ = 20 V, $V_{GE}$ = 0 V, f = 1 MHz	C <sub>ies</sub>	-	24146	_	pF	
Output Capacitance		C <sub>oes</sub>	-	1027	-		
Reverse Transfer Capacitance		C <sub>res</sub>	-	106	-		
Total Gate Charge	V <sub>CE</sub> = 600 V, I <sub>C</sub> = 375 A, V <sub>GE</sub> = -15 V~15 V	Qg	-	1249	-	nC	
Thermal Resistance – Chip-to-Heatsink	Thermal grease, Thickness = 2.1 Mil ±2%	R <sub>thJH</sub>	_	0.22	_	K/W	
Thermal Resistance - Chip-to-Case	λ = 2.9 W/mK	R <sub>thJC</sub>	_	0.12	-	K/W	

#### NEUTRAL POINT DIODE (D5, D6) CHARACTERISTICS

Diode Forward Voltage	I <sub>F</sub> = 100 A, T <sub>J</sub> = 25°C	V <sub>F</sub>	-	1.50	1.85	V
	I <sub>F</sub> = 100 A, T <sub>J</sub> = 150°C		_	2.07	_	
Reverse Recovery Time	T <sub>J</sub> = 25°C	t <sub>rr</sub>	-	19	-	ns
Reverse Recovery Charge	V <sub>CE</sub> =  600 V, I <sub>C</sub> =  150 A V <sub>GE</sub> = –8 V, 15 V, R <sub>G</sub> = 6 Ω	Q <sub>rr</sub>	-	229	_	nC
Peak Reverse Recovery Current		I <sub>RRM</sub>	-	19	-	А
Reverse Recovery Energy		E <sub>rr</sub>	-	164	_	μJ
Reverse Recovery Time	T <sub>J</sub> = 125°C	t <sub>rr</sub>	-	34	-	ns
Reverse Recovery Charge	V <sub>CE</sub> =  600 V, I <sub>C</sub> =  150 A V <sub>GF</sub> = –8 V, 15 V, R <sub>G</sub> = 6 Ω	Q <sub>rr</sub>	-	359	-	nC
Peak Reverse Recovery Current		I <sub>RRM</sub>	-	17	-	А
Reverse Recovery Energy		E <sub>rr</sub>	-	211	-	μJ
Thermal Resistance – Chip-to-Heatsink	Thermal grease, Thickness = 2.1 Mil $\pm$ 2% $\lambda$ = 2.9 W/mK	R <sub>thJH</sub>	_	0.42	-	K/W
Thermal Resistance - Chip-to-Case		R <sub>thJC</sub>	_	0.29	_	K/W

#### **INNER IGBT (T2, T3) CHARACTERISTICS**

Collector-Emitter Cutoff Current	$V_{GE}$ = 0 V, $V_{CE}$ = 1000 V	ICES	-	-	500	μΑ
Collector-Emitter Saturation Voltage	$V_{GE}$ = 15 V, I <sub>C</sub> = 400 A, T <sub>J</sub> = 25°C	V <sub>CE(sat)</sub>	_	1.75	2.3	V
	$V_{GE}$ = 15 V, I <sub>C</sub> = 400 A, T <sub>J</sub> = 150°C		_	2.11	-	
Gate-Emitter Threshold Voltage	$V_{GE} = V_{CE}$ , $I_C = 400 \text{ mA}$	V <sub>GE(TH)</sub>	4.1	5	6.1	V
Gate Leakage Current	$V_{GE}$ = ±20 V, $V_{CE}$ = 0 V	I <sub>GES</sub>	_	_	±2000	nA
Turn-on Delay Time	$T_{\rm J} = 25^{\circ} C$	t <sub>d(on)</sub>	_	70	_	ns
Rise Time	V <sub>CE</sub> =  600 V, I <sub>C</sub> =  150 A V <sub>GE</sub> = –9 V, 15 V, R <sub>G</sub> = 11 Ω	t <sub>r</sub>	—	31	-	
Turn-off Delay Time		t <sub>d(off)</sub>	_	423	-	
Fall Time		t <sub>f</sub>	—	74	-	
Turn-on Switching Loss per Pulse		E <sub>on</sub>	-	6.4	-	mJ
Turn-off Switching Loss per Pulse		E <sub>off</sub>	-	4.2	-	
Turn-on Delay Time	$T_{\rm J} = 125^{\circ}C$	t <sub>d(on)</sub>	—	66	-	ns
Rise Time	V <sub>CE</sub> =  600 V, I <sub>C</sub> =  150 A V <sub>GE</sub> = –9 V, 15 V, R <sub>G</sub> = 11 Ω	t <sub>r</sub>	_	31	-	
Turn-off Delay Time	1	t <sub>d(off)</sub>	—	509	-	
Fall Time	1	t <sub>f</sub>	—	88	-	
Turn-on Switching Loss per Pulse		Eon	—	9.7	-	mJ
Turn-off Switching Loss per Pulse		E <sub>off</sub>	—	8.2	-	
Input Capacitance	V <sub>CE</sub> = 20 V, V <sub>GE</sub> = 0 V, f = 1 MHz	C <sub>ies</sub>	_	26093	_	pF
Output Capacitance		C <sub>oes</sub>	—	1012	-	
Reverse Transfer Capacitance	]	C <sub>res</sub>	-	104	_	

### **ELECTRICAL CHARACTERISTICS** ( $T_J$ = 25°C unless otherwise specified) (continued)

Characteristic	Test Conditions	Symbol	Min	Тур	Max	Unit
INNER IGBT (T2, T3) CHARACTERISTICS						
Internal Gage Resistor		R <sub>gint</sub>	_	1.25	-	Ω
Total Gate Charge	V <sub>CE</sub> = 600 V, I <sub>C</sub> = 400 A, V <sub>GE</sub> = -15 V~15 V	Qg	-	1304	-	nC
Thermal Resistance – Chip-to-Heatsink	Thermal grease, Thickness = 2.1 Mil ±2%	R <sub>thJH</sub>	-	0.24	-	K/W
Thermal Resistance - Chip-to-Case	λ = 2.9 W/mK	R <sub>thJC</sub>	-	0.13	-	K/W

#### IGBT INVERSE DIODE (D1, D2, D3, D4) CHARACTERISTICS

Diode Forward Voltage	I <sub>F</sub> = 150 A, T <sub>J</sub> = 25°C	VF	_	2.06	2.6	V
blode i erward veltage		• -			2.0	·
	I <sub>F</sub> = 150 A, T <sub>J</sub> = 150°C		-	1.77	-	
Reverse Recovery Time	$T_{\rm J} = 25^{\circ} \rm C$	t <sub>rr</sub>	-	105	-	ns
Reverse Recovery Charge	V <sub>CE</sub> = 600 V, I <sub>C</sub> = 150 A V <sub>GE</sub> = -8 V, 15 V, R <sub>G</sub> = 6 Ω	Q <sub>rr</sub>	-	4179	-	nC
Peak Reverse Recovery Current		I <sub>RRM</sub>	-	97	-	Α
Reverse Recovery Energy		E <sub>rr</sub>	-	4665	_	μJ
Reverse Recovery Time	T <sub>J</sub> = 125°C	t <sub>rr</sub>	-	179	-	ns
Reverse Recovery Charge	V <sub>CE</sub> =  600 V, I <sub>C</sub> =  150 A V <sub>GE</sub> = –8 V, 15 V, R <sub>G</sub> = 6 Ω	Q <sub>rr</sub>	-	11900	_	nC
Peak Reverse Recovery Current		I <sub>RRM</sub>	-	133	-	А
Reverse Recovery Energy		E <sub>rr</sub>	-	3783	-	μJ
Thermal Resistance – Chip-to-Heatsink	Thermal grease, Thickness = 2.1 Mil ±2%	R <sub>thJH</sub>	_	0.39	-	K/W
Thermal Resistance - Chip-to-Case	λ = 2.9 W/mK	R <sub>thJC</sub>	-	0.25	_	K/W

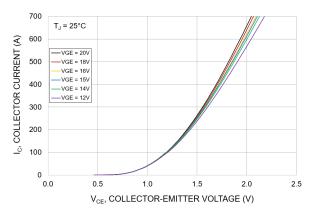
#### THERMISTOR CHARACTERISTICS

Nominal Resistance	T = 25°C	R <sub>25</sub>	-	22	_	kΩ
Nominal Resistance	T = 100°C	R <sub>100</sub>	-	1486	-	kΩ
Deviation of R25		$\Delta R/R$	-5	-	5	%
Power Dissipation		PD	-	200	—	mW
Power Dissipation Constant			-	2	—	mW/K
B-value	B(25/50), tolerance ±3%		-	3950	-	К
B-value	B(25/100), tolerance ±3%		-	3998	_	К

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### **ORDERING INFORMATION**

Part Number	Marking	Package	Shipping
NXH350N100H4Q2F2P1G, NXH350N100H4Q2F2P1G-R PRESS FIT PINS	NXH350N100H4Q2F2P1G, NXH350N100H4Q2F2P1G-R	Q2PACK (Pb-Free/Halide-Free)	12 Units / Blister Tray
NXH350N100H4Q2F2S1G, NXH350N100H4Q2F2S1G-R SOLDER PINS	NXH350N100H4Q2F2S1G, NXH350N100H4Q2F2S1G-R	Q2PACK (Pb-Free/Halide-Free)	12 Units / Blister Tray



# **TYPICAL CHARACTERISTICS – OUTER IGBT, INNER IGBT**



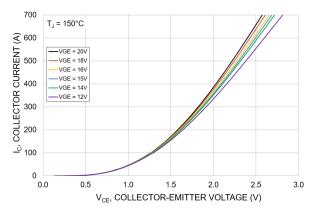


Figure 4. Typical Output Characteristics – Outer IGBT

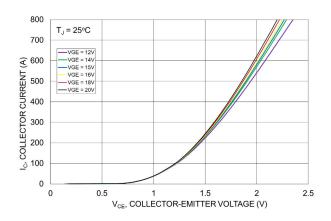


Figure 5. Typical Output Characteristics – Inner IGBT

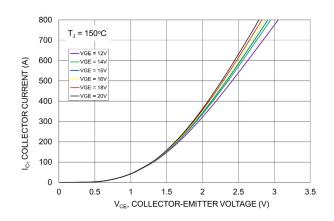


Figure 6. Typical Output Characteristics – Inner IGBT

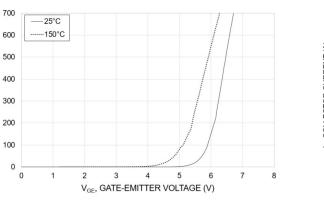


Figure 7. Transfer Characteristics – Outer IGBT

COLLECTOR CURRENT (A)

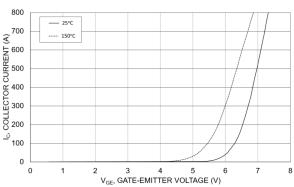


Figure 8. Transfer Characteristics – Inner IGBT

### TYPICAL CHARACTERISTICS – OUTER IGBT, INNER IGBT, IGBT INVERSE DIODE AND NEUTRAL POINT DIODE

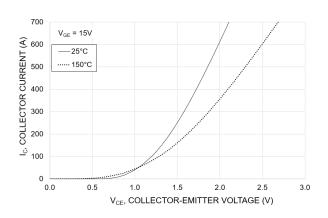


Figure 9. Typical Saturation Voltage Characteristics – Outer IGBT

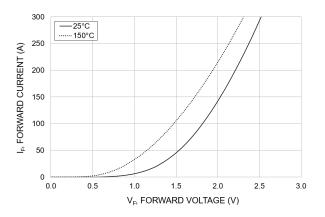


Figure 11. Inverse Diode Forward Characteristics

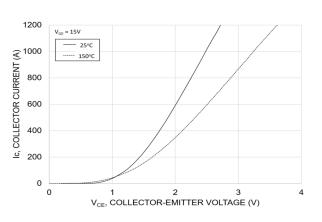


Figure 10. Typical Saturation Voltage Characteristics – Inner IGBT

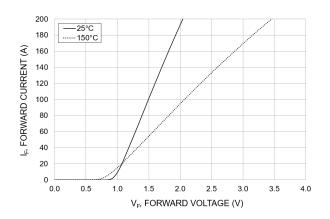
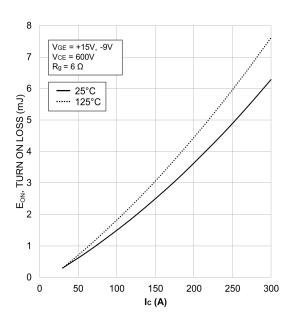


Figure 12. Buck Diode Forward Characteristics

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# **TYPICAL SWITCHING CHARACTERISTICS – OUTER IGBT**





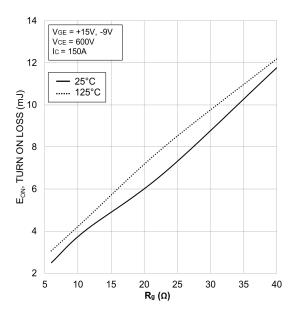


Figure 15. Typical Turn On Loss vs. R<sub>G</sub>

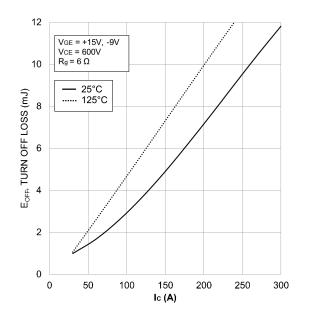


Figure 14. Typical Turn Off Loss vs. I<sub>C</sub>

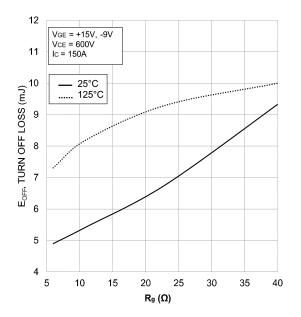


Figure 16. Typical Turn Off Loss vs. R<sub>G</sub>

# TYPICAL SWITCHING CHARACTERISTICS - OUTER IGBT (Continued)

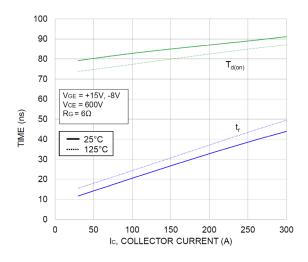


Figure 17. Typical Turn On Switching Time vs. I<sub>C</sub>

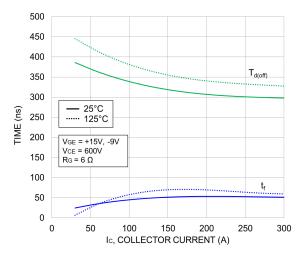


Figure 18. Typical Turn Off Switching Time vs. I<sub>C</sub>

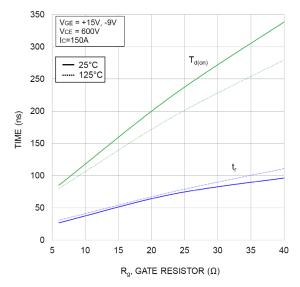


Figure 19. Typical Turn On Switching Time vs. R<sub>G</sub>

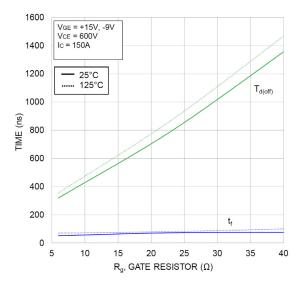


Figure 20. Typical Turn Off Switching Time vs. R<sub>G</sub>

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### **TYPICAL SWITCHING CHARACTERISTICS – INNER IGBT**

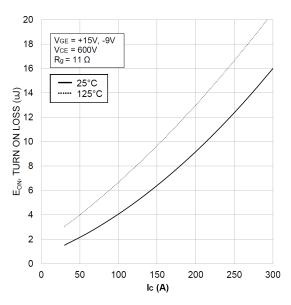


Figure 21. Typical Turn On Loss vs. I<sub>C</sub>

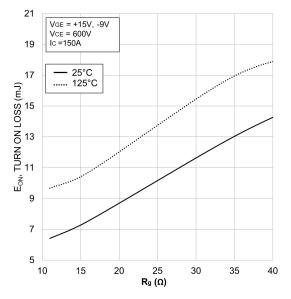


Figure 23. Typical Turn On Loss vs. R<sub>G</sub>

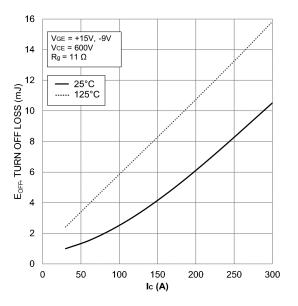


Figure 22. Typical Turn Off Loss vs.  $\rm I_C$ 

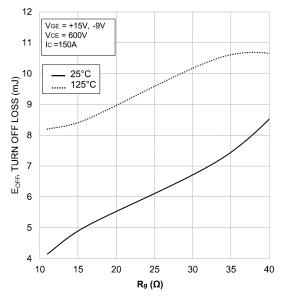


Figure 24. Typical Turn Off Loss vs. R<sub>G</sub>

### TYPICAL SWITCHING CHARACTERISTICS - INNER IGBT (Continued)

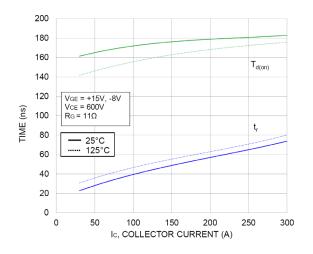


Figure 25. Typical Turn On Switching Time vs. I<sub>C</sub>

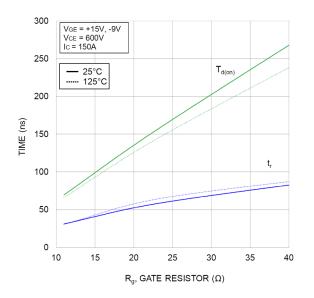


Figure 27. Typical Turn On Switching Time vs. R<sub>G</sub>

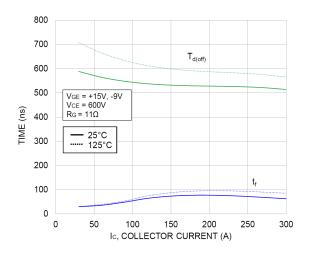


Figure 26. Typical Turn Off Switching Time vs. I<sub>C</sub>

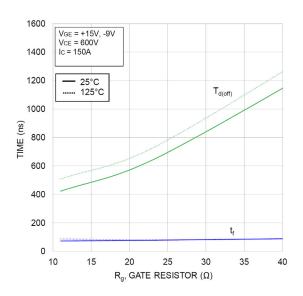
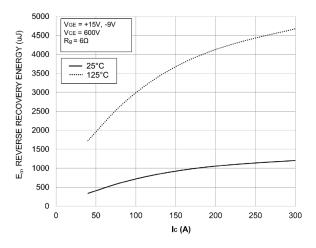
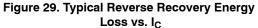


Figure 28. Typical Turn Off Switching Time vs. R<sub>G</sub>

### **TYPICAL SWITCHING CHARACTERISTICS – INVERSE DIODE**





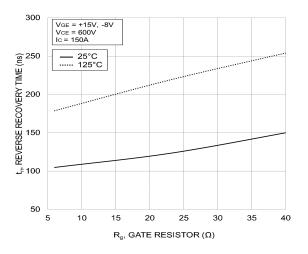
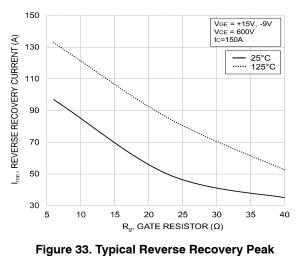


Figure 31. Typical Reverse Recovery Time vs. R<sub>G</sub>



Current vs. R<sub>G</sub>

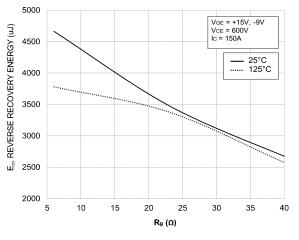


Figure 30. Typical Reverse Recovery Energy Loss vs. R<sub>G</sub>

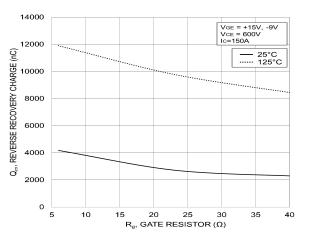
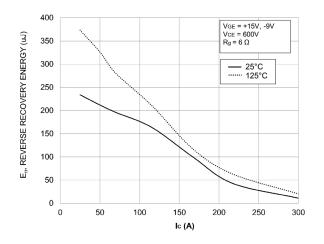
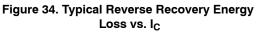


Figure 32. Typical Reverse Recovery Charge vs. R<sub>G</sub>

# 

## **TYPICAL SWITCHING CHARACTERISTICS – NEUTRAL POINT DIODE**





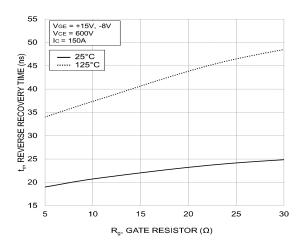
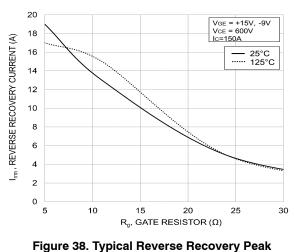


Figure 36. Typical Reverse Recovery Time vs. R<sub>G</sub>



Current vs. R<sub>G</sub>

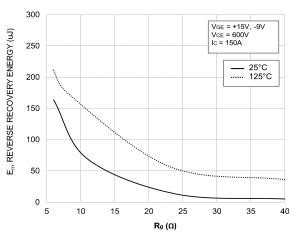


Figure 35. Typical Reverse Recovery Energy Loss vs. R<sub>G</sub>

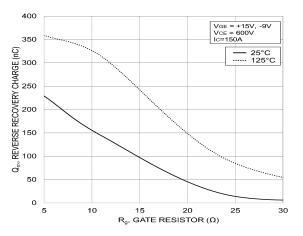


Figure 37. Typical Reverse Recovery Charge vs. R<sub>G</sub>

### NXH350N100H4Q2F2P1G, NXH350N100H4Q2F2S1G, NXH350N100H4Q2F2S1G-R, NXH350N100H4Q2F2P1G-R TRANSIENT THERMAL IMPEDANCE

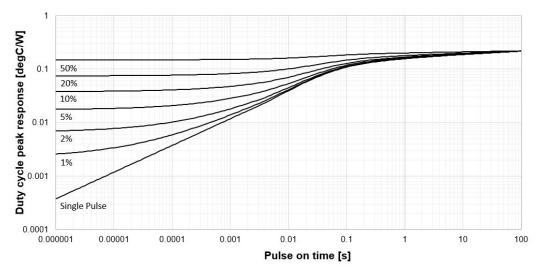


Figure 39. Transient Thermal Impedance – Outer IGBT

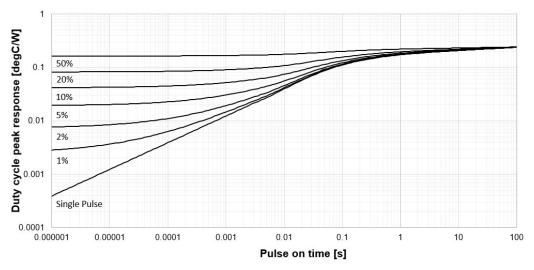


Figure 40. Transient Thermal Impedance – Inner IGBT

TRANSIENT THERMAL IMPEDANCE (Continued)

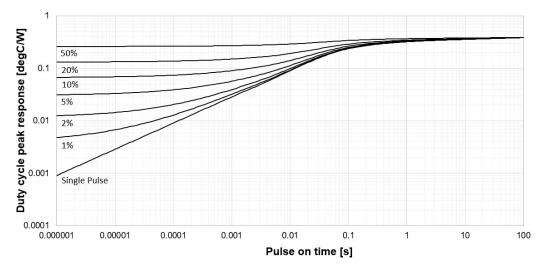


Figure 41. Transient Thermal Impedance – Inverse Diode

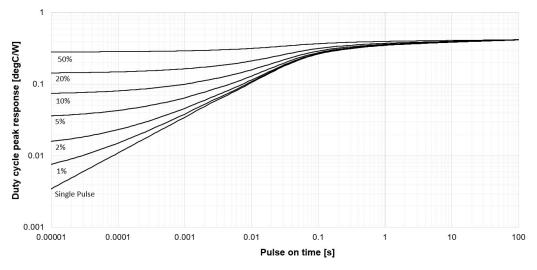


Figure 42. Transient Thermal Impedance – Neutral Point Diode

### NXH350N100H4Q2F2P1G, NXH350N100H4Q2F2S1G, NXH350N100H4Q2F2S1G-R, NXH350N100H4Q2F2P1G-R SAFE OPERATING AREA

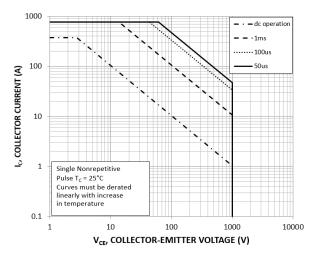


Figure 43. FBSOA – Outer IGBT

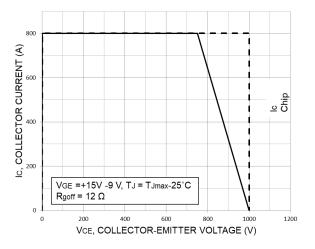


Figure 44. RBSOA – Outer IGBT

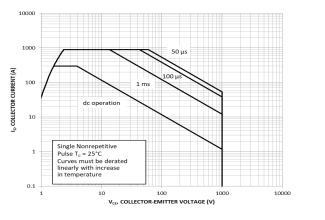


Figure 45. FBSOA – Inner IGBT

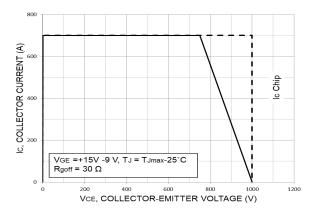
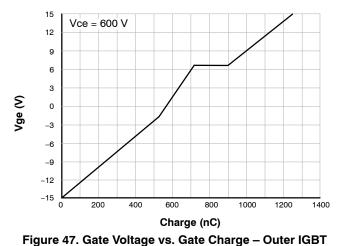


Figure 46. RBSOA – Inner IGBT

### NXH350N100H4Q2F2P1G, NXH350N100H4Q2F2S1G, NXH350N100H4Q2F2S1G-R, NXH350N100H4Q2F2P1G-R GATE CHARGE AND CAPACITANCE



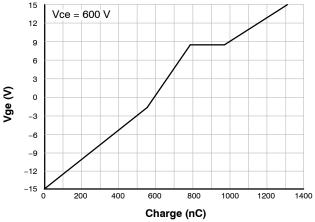


Figure 48. Gate Voltage vs. Gate Charge – Inner IGBT

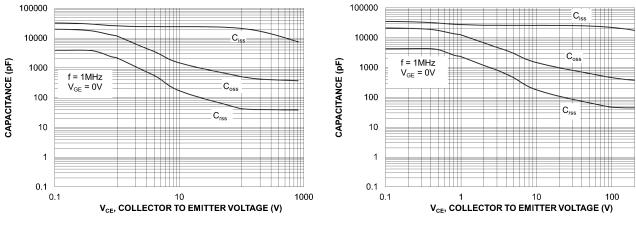
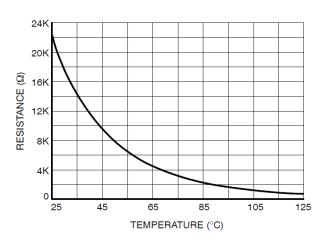


Figure 49. Capacitance Charge – Outer IGBT



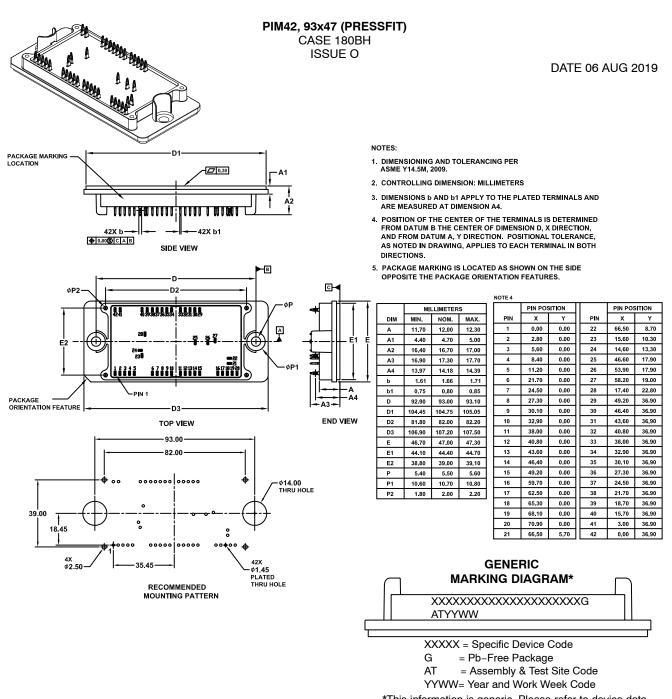


### **TYPICAL CHARCTERISTICS – THERMISTOR**

Figure 51. Thermistor Characteristics

#### MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS





\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

 
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#### MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS

ISSUE O DATE 03 DEC 2019 NOTES: PACKAGE MARKING 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009. LOCATION **D** 0.30 A1 2. CONTROLLING DIMENSION: MILLIMETERS 3. DIMENSIONS & AND & 1 APPLY TO THE PLATED TERMINALS AND ARE MEASURED AT DIMENSION A4 4. POSITION OF THE CENTER OF THE TERMINALS IS DETERMINED FROM DATUM B THE CENTER OF DIMENSION D, X DIRECTION, AND FROM DATUM A, Y DIRECTION. POSITIONAL TOLERANCE, AS NOTED IN DRAWING, APPLIES TO EACH TERMINAL IN BOTH 42X b DIRECTIONS 0.80**S** A B 5. PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE SIDE VIEW OPPOSITE THE PACKAGE ORIENTATION FEATURES. −В MULIMETERS DIM MIN. NOM. MAX. D2 ØP2 11.70 12.00 12.30 Α 4.40 4.70 5.00 A1 ö 4241 40 39 38 37 36 35 34 333231 3029 A2 16.40 16.70 17.00 А3 16.80 17.20 17.60 Α 28**0** b 0.95 1.00 1.05 26 27 **F1** E E2 + (+ D 92,90 93.00 93,10 24 O 230 D1 104.45 104.75 105.05 0 22 0 21 16 17 18 19 2 ØP1 D2 81.80 82.00 82.20 6 7 8 9 10 11 12 13 14 15 D3 107.20 107.50 106.90 Е 46.70 47.00 47.30 Α PIN 1 E1 44.10 44.40 44.70 A3 D3 F2 38.80 39.00 39.10 PACKAGE Р 5.40 5.50 5.60 END VIEW TOP VIEW **ORIENTATION FEATURE** P1 10.60 10.70 10.80 NOTE 4 P2 1.80 2.00 2.20 PIN POSITION PIN POSITION PIN х Y PIN х Y 1 0.00 0.00 22 66.50 8.70 2 2.80 0,00 23 15.60 10.30 3 5.60 0.00 24 14.60 13.30 8.40 0.00 25 46.60 17.90 4 11.20 0.00 26 53.90 17.90 5 21.70 27 6 0,00 58,20 19,00 7 24.50 0.00 28 17.40 22.80 GENERIC 8 27.30 0,00 29 49.20 36,90 **MARKING DIAGRAM\*** 9 30.10 0.00 30 46.40 36.90 XXXXXXXXXXXXXXXXXXXXXXXXXXXX 10 32,90 0,00 31 43,60 36,90 ATYYWW 11 38.00 0.00 32 40.80 36,90 12 40.80 0.00 33 38.00 36.90 XXXXX = Specific Device Code 13 43.60 0.00 34 32.90 36.90 G = Pb-Free Package 14 46.40 0,00 35 30.10 36,90 = Assembly & Test Site Code 15 49.20 0.00 36 27.30 36.90 AT YYWW= Year and Work Week Code 16 59.70 37 24.50 36.90 0.00 17 62.50 0.00 38 36.90 21.70 \*This information is generic. Please refer to device data 18 39 65.30 0.00 18.70 36.90 sheet for actual part marking. Pb-Free indicator, "G" or 19 68.10 0.00 40 15.70 36.90 microdot "•", may or may not be present. Some products may not follow the Generic Marking. 20 70.90 0.00 41 3.00 36.90 21 66.50 5.70 42 0.00 36.90 Electronic versions are uncontrolled except when accessed directly from the Document Repository. DOCUMENT NUMBER: 98AON15232H Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red. **DESCRIPTION:** PIM42 93X47 (SOLDER PIN) PAGE 1 OF 1 ON Semiconductor and unarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding

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